## Search Notes



10646428

Applicant(s)/Patent Under Reexamination HAWLEY, DAVID

Examiner

Art Unit

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2191

## **SEARCHED**

Class	Subclass	Date	Examiner
717	104-119	1/5/2007	SR (SR)
		(Updated on	
		6/15/07)	

## **SEARCH NOTES**

Search Notes	Date	Examiner
East (all database)	1/5/2007 (Updated on 6/15/07)	SR (SR)
Inventor Name Search	1/5/2007	SR
Plus Search	1/4/2007	SR
NPL (IEEE)	1/5/2007	SR
Text Search	1/5/2007 (Updated on 6/15/07)	SR (SR)
Wei Zhen, SPE (discussed regards to 101 rejections)	1/4/2007	SR
Wei Zhen, SPE (discussed regards to 101 rejections)	6/18/07	SR

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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